

Search Notes

Application/Control No.

10/518,756

Examiner

PAUL T. CHIN

Applicant(s)/Patent under
Reexamination

YOKOYAMA ET AL.

Art Unit

3652

SEARCHED

Class	Subclass	Date	Examiner
623	64	12/28/2008	PTC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR